



# Solid State Devices, Inc.

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## SFS3027 - SFS3029 Series

### Designer's Data Sheet

#### Part Number/Ordering Information <sup>1/</sup>

SFS302

#### Screening <sup>2/</sup>

— = Not Screened  
TX = TX Level  
TXV = TXV Level  
S = S Level

#### Package

S.22 = SMD.22  
/18 = TO-18

#### Voltage/Family

7 = 30V  
8 = 60V  
9 = 100V

**0.5 AMP, 30 - 100 Volt  
FAST SWITCHING  
SILICON CONTROLLED  
RECTIFIER**

#### FEATURES:

- Passivated Planar Construction
- Low On-State Voltage and Fast Switching
- Hermetically Sealed Surface Mount Power Package
- Replacement for 2N3027 – 2N3029 Series - Contact Factory for Additional SCR Products

| MAXIMUM RATINGS <sup>3/</sup>   |         | Symbol          | Value       | Unit  |
|---|---------|-----------------|-------------|-------|
| Peak Repetitive Reverse Voltage and DC Blocking Voltage               | SFS3027 | $V_{DRM}$       | 30          | Volts |
|   | SFS3028 | $V_{RRM}$       | 60          |       |
|   | SFS3029 |                 | 100         |       |
| Non-Repetitive Peak Reverse Blocking Voltage (t < 5.0 ms)             | SFS3027 | $V_{RSM}$       | 50          | Volts |
|   | SFS3028 |                 | 100         |       |
|   | SFS3029 |                 | 200         |       |
| RMS On-State Current, (All Conduction Angles, T <sub>c</sub> = 100°C) |         | $I_T (RMS)$     | 0.5         | Amps  |
| Peak Non-Repetitive Surge Current (One Cycle, 60 Hz)                  |         | $I_{TSM}$       | 8           | Amps  |
| Peak Gate Power   |         | $P_{GM}$        | 0.1         | Watts |
| Average Gate Current  |         | $I_{G(ave)}$    | 0.025       | Amps  |
| Peak Gate Current   |         | $I_{GM}$        | 0.25        | Amps  |
| Reverse Gate Current  |         | $I_{GR}$        | 0.003       | Amps  |
| Reverse Gate Voltage  |         | $V_{GM}$        | 5.0         | Volts |
| Operating Junction Temperature Range                                  |         | $T_J$           | -65 to +150 | °C    |
| Storage Temperature Range   |         | $T_{stg}$       | -65 to +200 | °C    |
| Thermal Resistance, Junction to Case                                  |         | $R_{\theta JC}$ | 15          | °C/W  |

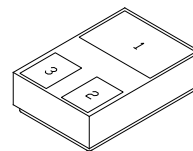
#### NOTES:

<sup>1/</sup> For ordering information, price, operating curves, and availability- Contact factory.

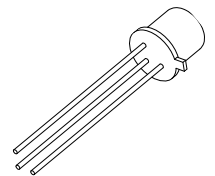
<sup>2/</sup> Screening based on MIL-PRF-19500. Screening flows available on request.

<sup>3/</sup> Unless otherwise specified, all electrical characteristics @ 25°C.

SMD.22



TO-18



NOTE: All specifications are subject to change without notification. SCD's for these devices should be reviewed by SSDI prior to release.

DATA SHEET #: SCR010E

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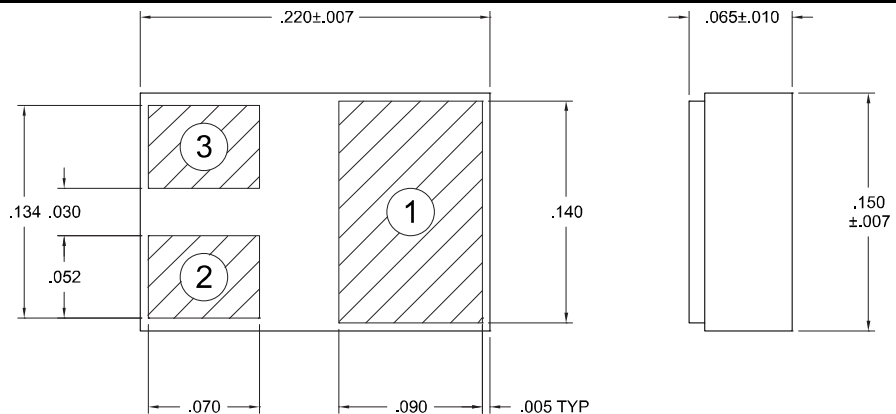
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| ELECTRICAL CHARACTERISTICS <sup>3/</sup>  |  | Symbol       | Min  | Typical | Max  | Unit       |
|---|--|--------------|------|---------|------|------------|
| <b>Peak Reverse Blocking Current</b><br>Rated $V_{RRM}$ , $R_{GK} = 1000 \Omega$          | $T_C = 25^\circ C$                           | $I_{RRM}$    | —    | 0.08    | 0.1  | $\mu A$    |
|   | $T_C = 150^\circ C$                          |              | —    | 20      | 50   |            |
| <b>Peak Forward Blocking Current</b><br>Rated $V_{DRM}$ , $R_{GK} = 1000 \Omega$          | $T_C = 25^\circ C$                           | $I_{DRM}$    | —    | 0.08    | 0.1  | $\mu A$    |
|   | $T_C = 150^\circ C$                          |              | —    | 30      | 50   |            |
| <b>Peak On-State Voltage</b><br>$I_F = 1.0 A$ pulse                                       |  | $V_{TM}$     | 0.8  | 1.1     | 1.5  | V          |
| <b>Gate Trigger Current</b><br>$V_D = 5 V_{DC}$ , $R_L = 100 \Omega$ , $R_e = 10 k\Omega$ | $T_C = 25^\circ C$                           | $I_{GT}$     | —    | 25      | 200  | $\mu A$    |
|   | $T_C = -65^\circ C$                          |              | —    | 50      | 1200 |            |
| <b>Gate Trigger Voltage</b><br>$V_D = 5 V_{DC}$ , $R_L = 100 \Omega$ , $R_e = 100 \Omega$ | $T_C = 25^\circ C$                           | $V_{GT}$     | 0.4  | 0.55    | 0.8  | V          |
|   | $T_C = -65^\circ C$                          |              | 0.6  | 0.75    | 1.1  |            |
|   | $T_C = 150^\circ C$                          |              | 0.1  | 0.20    | 0.6  |            |
| <b>Holding Current</b><br>$V_D = 5 V_{DC}$  | $T_C = 25^\circ C$ , $R_{GK} = 1000 \Omega$  | $I_H$        | 0.3  | 1.0     | 5.0  | mA         |
|   | $T_C = -65^\circ C$ , $R_{GK} = 1000 \Omega$ |              | 0.5  | 1.5     | 10.0 |            |
|   | $T_C = 150^\circ C$ , $R_{GK} = 2000 \Omega$ |              | 0.05 | 0.38    | 1.0  |            |
| <b>Off-State Voltage-Critical Rate of Rise</b>  |  | $dv_c/dt$    | 30   | —       | —    | V/ $\mu s$ |
| <b>Gate Trigger-on Pulse Width</b><br>Per Fig. 1  |  | $t_{pg(on)}$ | —    | 0.25    | 0.40 | $\mu s$    |
| <b>Gate Trigger-on Delay Time</b>   |  | $t_d$        | —    | 0.10    | —    | $\mu s$    |
| <b>Gate Trigger-on Rise Time</b><br>Per Fig. 1 with C1 = 0 and C2 = 0                     |  | $t_r$        | —    | 0.75    | —    | $\mu s$    |

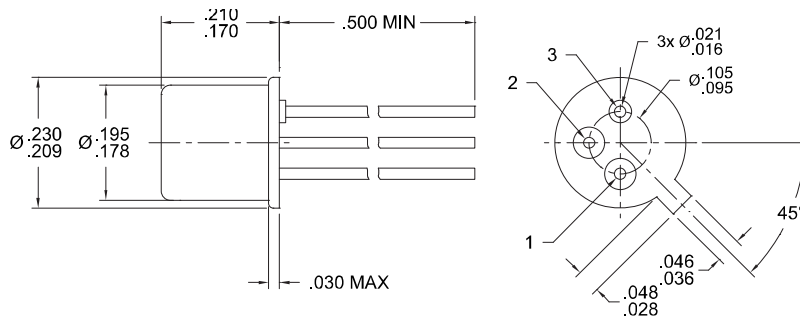
**Case Outline: SMD.22**

PAD 1: ANODE  
 PAD 2: CATHODE  
 PAD 3: GATE



**Case Outline: TO-18**

PIN 1: CATHODE  
 PIN 2: GATE  
 PIN 3: ANODE



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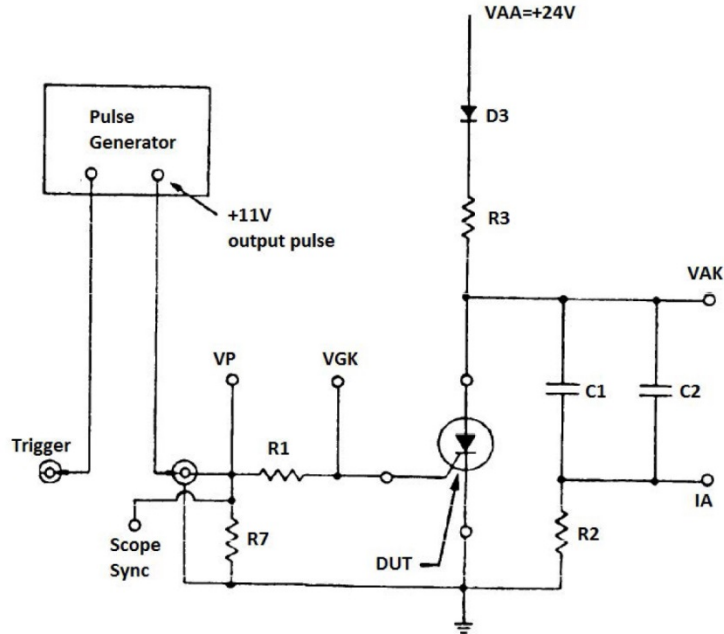
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**Fig. 1 Test Circuit for tpg(on), td and tr**

**Legends of circuit Element:** R1=1k, R2=30 non-inductive, R3=500 2W, R7=56, C1=1uF, C2=0.1uF ceramic, D3=1N457A (optional)

### **tpg(on) Test Procedure:**

1. Can use DC or pulsating AC 60Hz for VAA. If VAA is pulsating AC then D3 must be used, and trigger to Pulse Gen should be synchronized.
2. With specified VAA, IF and IGF initially established, connect a high frequency oscilloscope vertical input to the IA monitor point. The width of the gate current pulse is then set to a value that causes triggering to occur. The pulse width at this point is the gate trigger-on pulse width.
3. For additional details, see Mil-S-19500/419(EL).

### **td and tr Test Procedure:**

1. Remove C1 and C2, and set gate pulse width >2us.
2. Measure td from leading edge of gate pulse to 10% of VAK falling edge.
3. Measure tr from 10% to 90% of VAK falling edge.

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